Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/827,128	HOEHNE ET AL.
Examiner	Art Unit
Richard K. Lee	2832

SEARCHED			
Class	Subclass	Date	Examiner
200	520	9/3/2005	KL
	314		
	345		
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Y	310		
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST print out	9/3/2005	KL